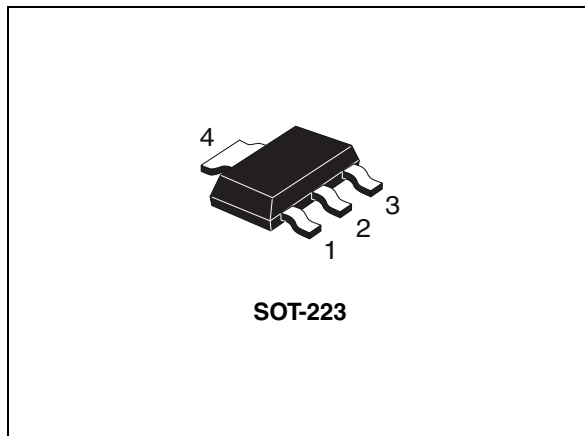


## P-channel 60 V, 0.13 $\Omega$ typ., 3 A STripFET™ VI DeepGATE™ Power MOSFET in a SOT-223 package

Datasheet - production data



### Features

Order code	V <sub>DSS</sub>	R <sub>DS(on)max</sub>	I <sub>D</sub>
STN3P6F6	60 V	0.16 $\Omega$ @ 10 V	3 A

- R<sub>DS(on)</sub> \* Qg industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses

### Applications

- Switching applications

### Description

This device is a P-channel Power MOSFET developed using the 6<sup>th</sup> generation of STripFET™ DeepGATE™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Figure 1. Internal schematic diagram

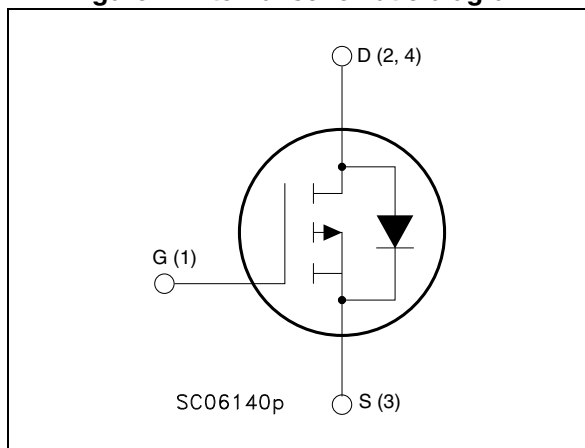


Table 1. Device summary

Order code	Marking	Package	Packaging
STN3P6F6	STN3P6F6	SOT-223	Tape and reel

**Note:** For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	60	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D$	Drain current (continuous) at $T_{pcb} = 25\text{ }^\circ\text{C}$	3	A
$I_D$	Drain current (continuous) at $T_{pcb} = 100\text{ }^\circ\text{C}$	2	A
$I_{DM}$	Drain current (pulsed)	12	A
$P_{TOT}^{(1)}$	Total dissipation at $T_{pcb} = 25\text{ }^\circ\text{C}$	2.6	W
$T_j$ $P_{stg}$	Operating junction temperature Storage temperature	-55 to 175	$^\circ\text{C}$

1. Pulse width is limited by safe operating area.

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	57	$^\circ\text{C/W}$

1. When mounted on FR-4 board of  $15\text{ mm}^2$ , 2 Oz Cu,  $t < 10\text{ sec}$

*Note:* For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified).

**Table 4. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 250 μA	60			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 60 V V <sub>DS</sub> = 60 V, T <sub>C</sub> = 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2		4	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A		0.13	0.16	Ω

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C <sub>iss</sub>	Input capacitance	V <sub>DS</sub> = 48 V, f = 1 MHz, V <sub>GS</sub> = 0	-	340	-	pF
C <sub>oss</sub>	Output capacitance			40		pF
C <sub>rss</sub>	Reverse transfer capacitance			20		pF
Q <sub>g</sub>	Total gate charge	V <sub>DD</sub> = 48 V, I <sub>D</sub> = 3 A,	-	6.4	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V		1.7		nC
Q <sub>gd</sub>	Gate-drain charge	(see <a href="#">Figure 14</a> )		1.7		nC

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 48 V, I <sub>D</sub> = 1.5 A, R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see <a href="#">Figure 13</a> )	-	6.4	-	ns
t <sub>r</sub>	Rise time			5.3		ns
t <sub>d(off)</sub>	Turn-off delay time			14		ns
t <sub>f</sub>	Fall time			3.7		ns

**Note:** For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		3	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		12	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 3\text{ A}, V_{GS} = 0$	-		1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	-	20		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 16\text{ V}, T_j = 150\text{ }^\circ\text{C}$	-	17.8		nC
$I_{RRM}$	Reverse recovery current	(see <a href="#">Figure 15</a> )	-	1.8		A

1. Pulse width limited by safe operating area.
2. Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

*Note:* For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

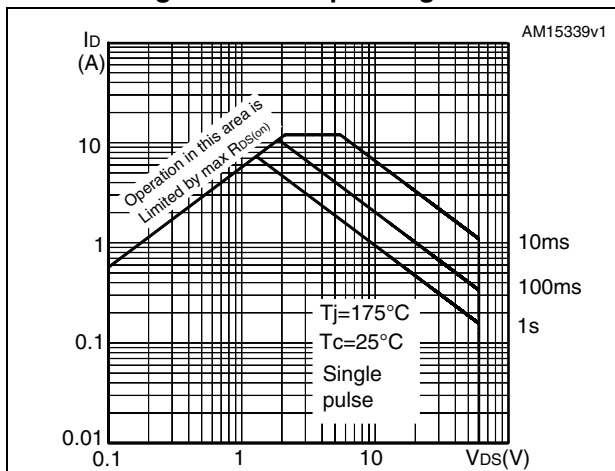


Figure 3. Thermal impedance

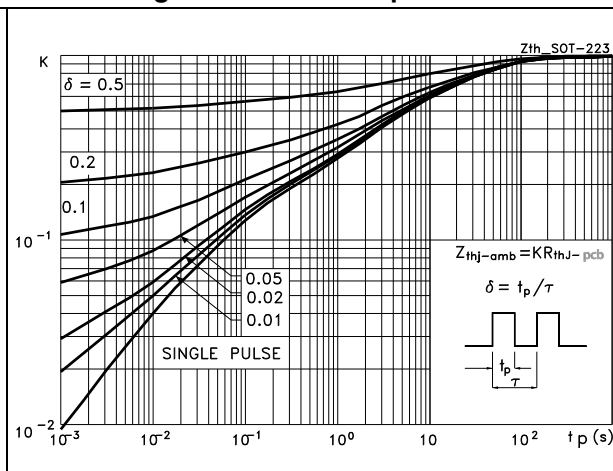


Figure 4. Output characteristics

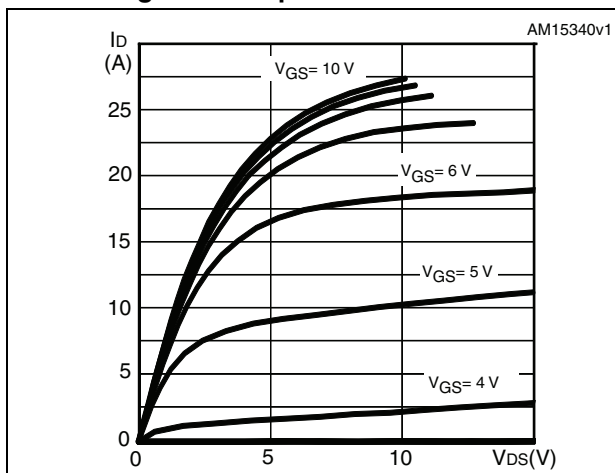


Figure 5. Transfer characteristics

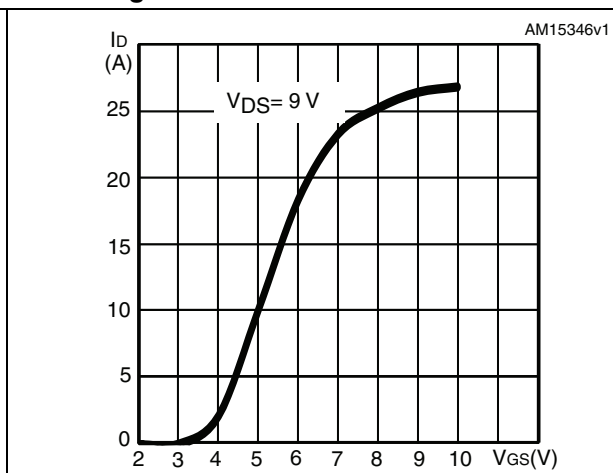


Figure 6. Gate charge vs gate-source voltage

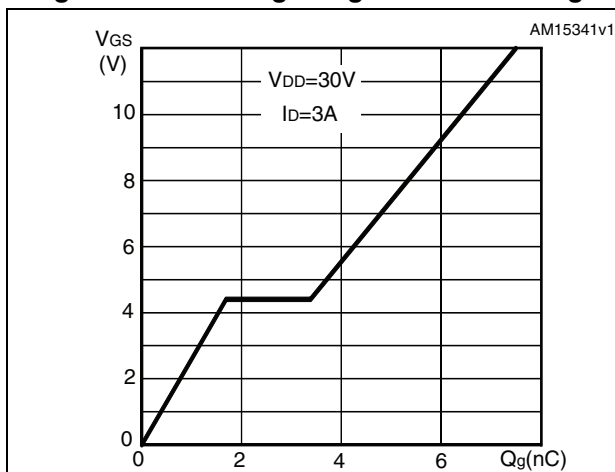


Figure 7. Static drain-source on-resistance

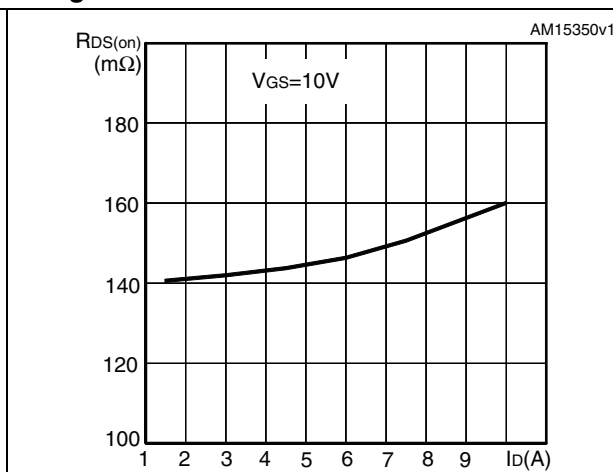


Figure 8. Capacitance variations

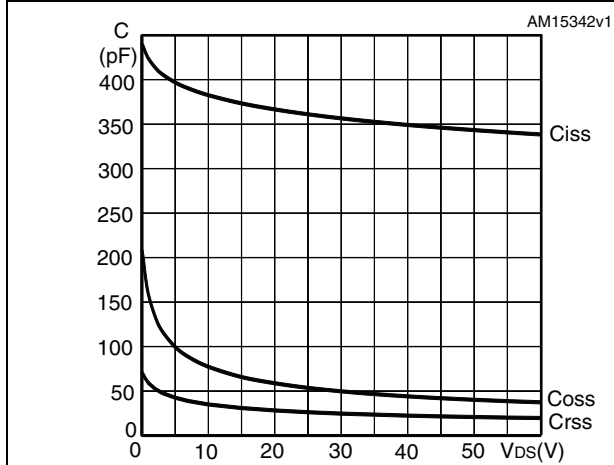


Figure 9. Normalized  $B_{VDSS}$  vs temperature

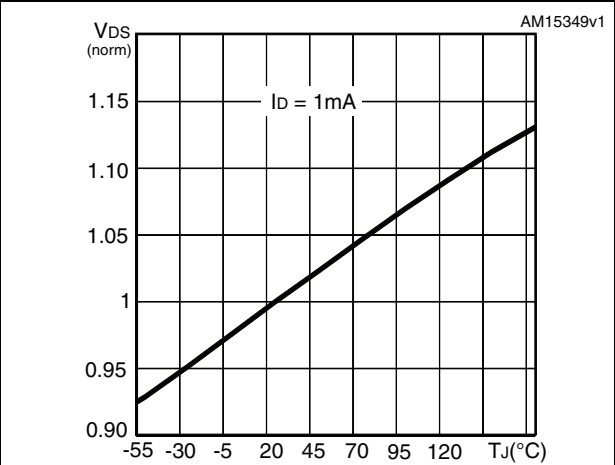


Figure 10. Normalized gate threshold voltage vs temperature

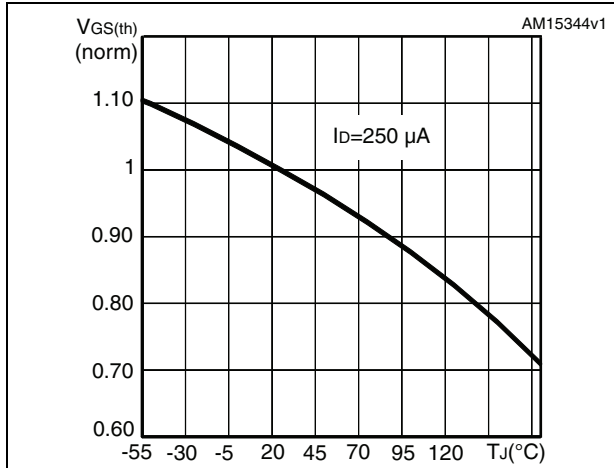


Figure 11. Normalized on-resistance vs temperature

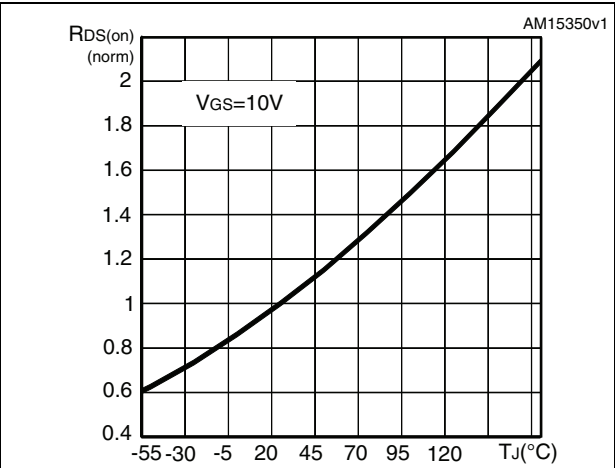
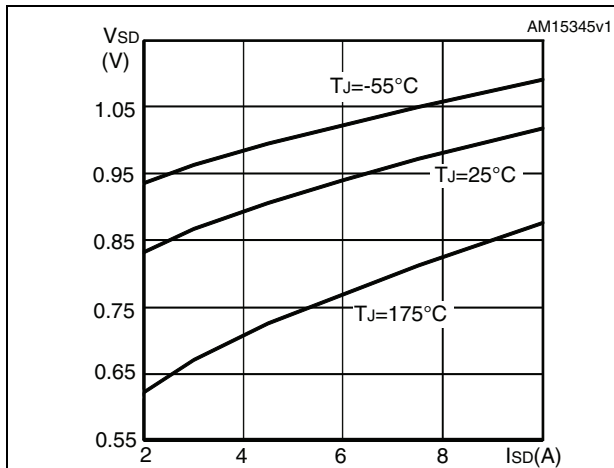
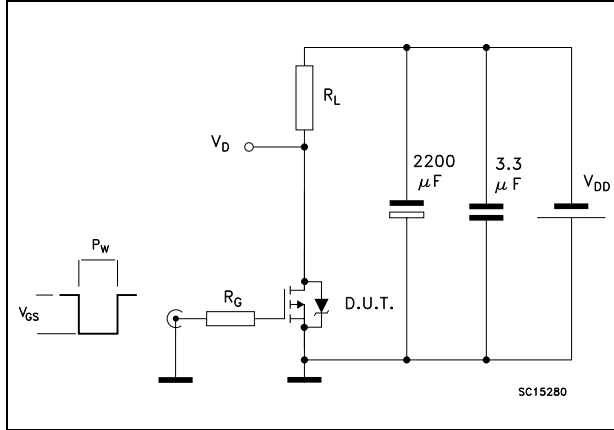


Figure 12. Source-drain diode forward characteristics

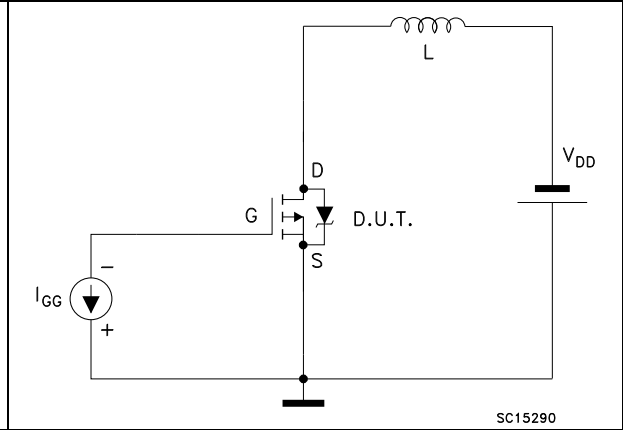


### 3 Test circuits

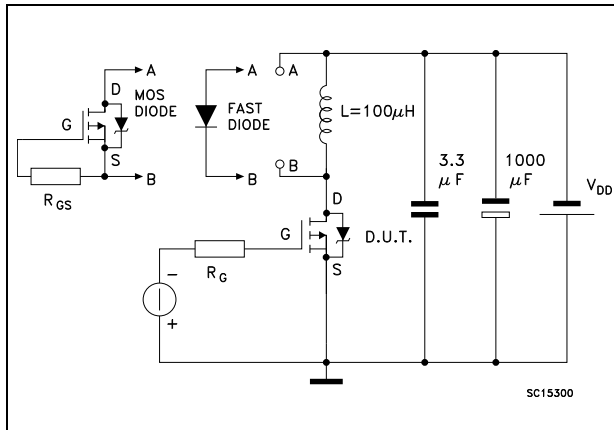
**Figure 13. Switching times test circuit for resistive load**



**Figure 14. Gate charge test circuit**



**Figure 15. Test circuit for inductive load switching and diode recovery times**





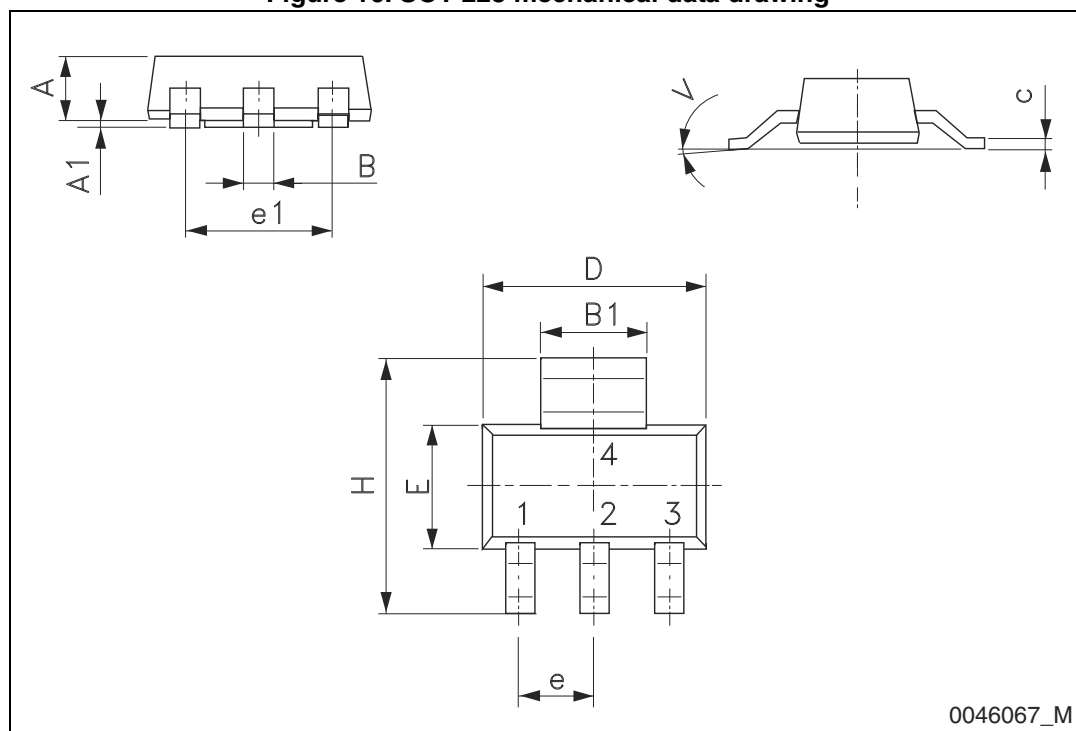
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

Table 8. SOT-223 mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A			1.80
A1	0.02		0.1
B	0.60	0.70	0.85
B1	2.90	3.00	3.15
c	0.24	0.26	0.35
D	6.30	6.50	6.70
e		2.30	
e1		4.60	
E	3.30	3.50	3.70
H	6.70	7.00	7.30
V			10°

Figure 16. SOT-223 mechanical data drawing



## 5 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
31-Oct-2012	1	First release.
09-Nov-2012	2	Modified: <a href="#">note 1</a> in <a href="#">Table 3</a>
16-Jan-2013	3	Document status promoted from preliminary data to production data
14-Mar-2013	4	Modified: <a href="#">Figure 1, 3</a> , $C_{ISS}$ , $C_{OSS}$ , $C_{RSS}$ typical values in <a href="#">Table 5</a>

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